

<b>Notice of References Cited</b>	Application/Control No. 10/749,755	Applicant(s)/Patent Under Reexamination SCHULTZ, RICHARD J.	
	Examiner Mark Spisich	Art Unit 1744	Page 1 of 1

#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,108,847	08-2000	Cueman et al.	15/104.94
	B	US-2003/0035953	02-2003	Weihrauch, Georg	428/375
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	11-33042	02-1999	JP	--	--
	O	6-38832	02-1994	JP	--	--
	P	3-289905	12-1991	JP	--	--
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.